

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 09/972,229 WEE ET AL.	
		Examiner	Art Unit Eleni A Shiferaw 2136	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,532,265 B1	03-2003	Van der Auwera et al.	375/240.16
	C	US-6,055,316 A	04-2000	Perlman et al.	380/262
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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